

## **APPLICATION**

- DC motor control
- ◆ UPS
- Class D Amplifier

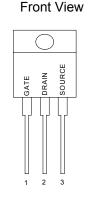
V <sub>DSS</sub>	R <sub>DS(ON)</sub> Typ.	I <sub>D</sub>			
60V	15.8mΩ	60A			
PIN CONFIGURATION					

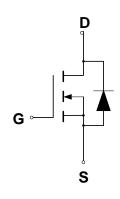
TO-220

### **FEATURES**

- ♦ Low ON Resistance
- ◆ Low Gate Charge
- ♦ Peak Current vs Pulse Width Curve
- Inductive Switching Curves

# **SYMBOL**





N-Channel MOSFET

# **ABSOLUTE MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Drain to Source Voltage (Note 1)	$V_{DSS}$	60	V
Drain to Current − Continuous Tc = 25°C, V <sub>GS</sub> @10V	I <sub>D</sub>	60	Α
<ul><li>Continuous Tc = 100°C, V<sub>GS</sub>@10V</li></ul>	I <sub>D</sub>	43	
- Pulsed Tc = 25°ℂ, V <sub>GS</sub> @10V (Note 2)	I <sub>DM</sub>	241	
Gate-to-Source Voltage — Continue	$V_{GS}$	±20	V
Total Power Dissipation	P <sub>D</sub>	150	W
Derating Factor above 25°ℂ		1.0	W/°C
Peak Diode Recovery dv/dt (Note 3)	dv/dt	4.5	V/ns
Operating Junction and Storage Temperature Range	T <sub>J</sub> , T <sub>STG</sub>	-55 to 175	$^{\circ}\!\mathbb{C}$
Single Pulse Avalanche Energy L=144µH,I <sub>D</sub> =40 Amps	E <sub>AS</sub>	500	mJ
Maximum Lead Temperature for Soldering Purposes	$T_L$	300	$^{\circ}\!\mathbb{C}$
Maximum Package Body for 10 seconds	$T_{PKG}$	260	$^{\circ}\!\mathbb{C}$
Pulsed Avalanche Rating	I <sub>AS</sub>	60	Α

### THERMAL RESISTANCE

Symbol	Parameter	Min	Тур	Max	Units	Test Conditions
$R_{\theta JC}$	Junction-to-case			1.0	°C/W	Water cooled heatsink, PD adjusted for a peak junction
						temperature of +175°C
$R_{\theta JA}$	Junction-to-ambient			62	°C/W	1 cubic foot chamber, free air



### ORDERING INFORMATION

Part Number	Package		
CMT60N06G	TO-220		

### **ELECTRICAL CHARACTERISTICS**

Unless otherwise specified,  $T_J = 25^{\circ}C$ .

			CMT60N06G			
Cha	Symbol	Min	Тур	Max	Units	
	OFF Characterist	ics				
Drain-to-Source Breakdown Voltage	$V_{DSS}$	60			V	
$(V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A})$						
Breakdown Voltage Temperature Co	efficient	$\DeltaV_{DSS}\!/\!\Delta T_{J}$		0.069		mV/°C
(Reference to 25 $^{\circ}$ C , $I_D$ = 250 $\mu$ A)						
Drain-to-Source Leakage Current		I <sub>DSS</sub>				μΑ
$(V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 25^{\circ}\text{C})$					25	
$(V_{DS} = 48 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150^{\circ}C$	)				250	
Gate-to-Source Forward Leakage		$I_{GSS}$			100	nA
(V <sub>GS</sub> = 20 V)						
Gate-to-Source Reverse Leakage		$I_{GSS}$			-100	nA
(V <sub>GS</sub> = -20 V)						
	ON Characterist	ics		1	ı	1
Gate Threshold Voltage		$V_{GS(th)}$	1.0	2.0	3.0	V
$(V_{DS} = V_{GS}, I_D = 250 \mu A)$						
Static Drain-to-Source On-Resistand	e (Note 4)	R <sub>DS(on)</sub>				mΩ
$(V_{GS} = 10 \text{ V}, I_D = 60\text{A})$			15.8	18		
Forward Transconductance ( $V_{DS} = 1$ )	<b>g</b> FS		36		S	
	Dynamic Character	istics		1	Γ	1
Input Capacitance	$(V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	C <sub>iss</sub>		1430		pF
Output Capacitance	f = 1.0 MHz)	C <sub>oss</sub>		420		pF
Reverse Transfer Capacitance	,	$C_{rss}$		88		pF
Total Gate Charge (V <sub>GS</sub> = 10 V)	$(V_{DS} = 30 \text{ V}, I_{D} = 60 \text{ A},$	Qg		37.7		nC
Gate-to-Source Charge	V <sub>GS</sub> = 10 V) (Note 5)	$Q_{gs}$		8.4		nC
Gate-to-Drain ("Miller") Charge		$Q_{gd}$		9.8		nC
	Resistive Switching Cha	racteristics		1	ı	1
Turn-On Delay Time	$(V_{DD} = 30 \text{ V}, I_D = 60 \text{ A},$	$t_{d(on)}$		12.1		ns
Rise Time	$V_{GS} = 10 \text{ V},$	t <sub>rise</sub>		64		ns
Turn-Off Delay Time	$R_G = 9.1\Omega$ ) (Note 5)	$t_{\sf d(off)}$		69		ns
Fall Time		t <sub>fall</sub>		39		ns
	Source-Drain Diode Cha			1		1
Continuous Source Current		Is			60	Α
(Body Diode)	Integral pn-diode in MOSFET					
Pulse Source Current (Body Diode)		I <sub>SM</sub>			241	Α
Diode Forward On-Voltage	(I <sub>S</sub> = 60 A, V <sub>GS</sub> = 0 V)	V <sub>SD</sub>			1.5	V
Reverse Recovery Time	$(I_F = 60A, V_{GS} = 0 V,$	t <sub>rr</sub>		55		ns
Reverse Recovery Charge	$d_i/d_t = 100A/\mu s)$	$Q_{rr}$		110		nC

Note 1:  $T_J = +25^{\circ}C$  to  $+175^{\circ}C$ 

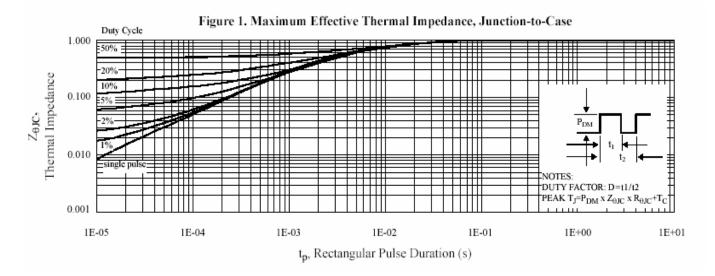
Note 2: Repetitive rating; pulse width limited by maximum junction temperature.

Note 3:  $I_{SD}$  = 60A, di/dt  $\leq$ 100A/ $\mu$ s,  $V_{DD} \leq BV_{DSS}$ ,  $T_{J}$  = +175 $^{\circ}$ C

Note 4: Pulse width < 250µs; duty cycle<2%

Note 5: Essentially independent of operating temerpature.





Ip, Drain Current (A)

Figure 2. Maximum Power Dissipation vs Case Temperature

(M) uojtadissid 100 100 100 80 60 40 20 0 125 150 175 T<sub>C</sub>, Case Temperature (°C)

Figure 3. Maximum Continuous Drain Current vs Case Temperature

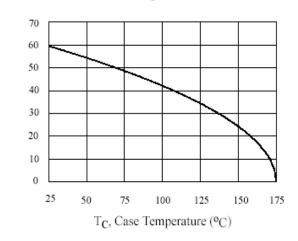


Figure 4. Typical Output Characteristics

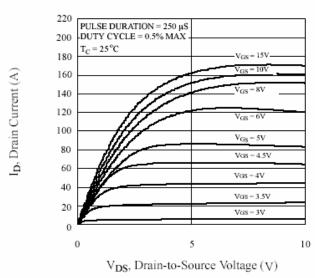
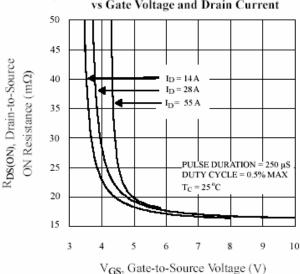
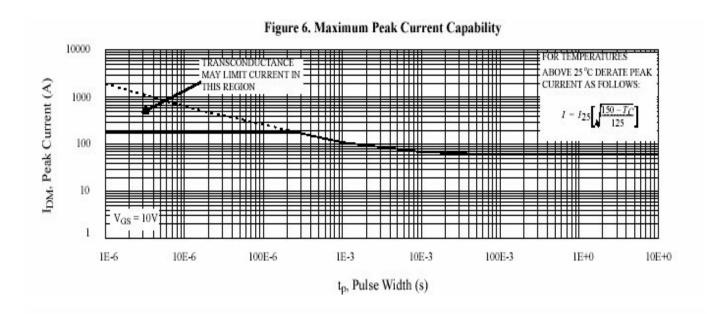


Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current

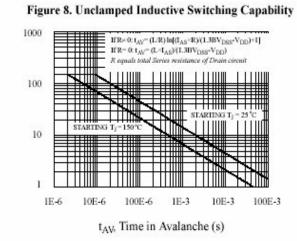


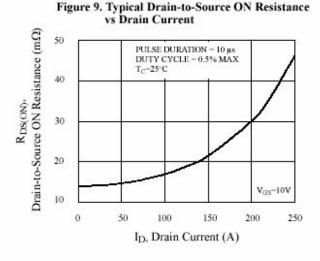




(A) Avalanche Current (A)

Figure 7. Typical Transfer Characteristics 40 ID, Drain-to-Source Current (A) PULSE DURATION - 250 µs DUTY CYCLE = 0.5% MAX V<sub>DS</sub> = 10 V 35 30 25 20 15 +175°C 10 +25°C -55°C 5 1.5 2.0 3.5 4.0 VGS, Gate-to-Source Voltage (V)





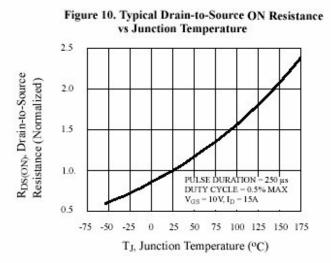
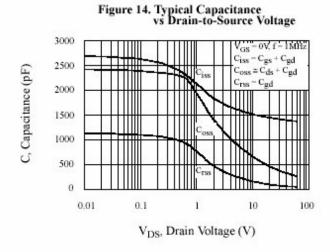
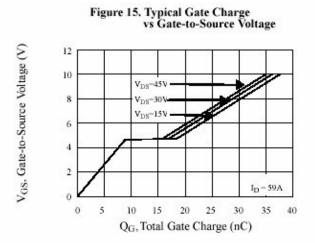


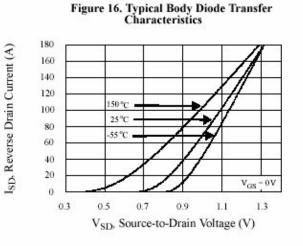


Figure 11. Typical Breakdown Voltage vs Junction Temperature Breakdown Voltage (Normalized) 1.20 BV<sub>DSS</sub>, Drain-to-Source 1.15 1.10 1.05  $V_{GS} = 0V$ 0.95  $I_D = 250 \, \mu A$ 0.90 50 75 100 125 150 175 -75 -50 25 T<sub>J</sub>, Junction Temperature (°C)

Figure 12. Typical Threshold Voltage vs Junction Temperature 1.2 VGS(TH), Threshold Voltage 1.1 1.0 (Normalized) 0.9 0.8 0.7  $V_{GS} = V_{DS}$ 0.6  $I_D = 250 \mu A$ 0.5 -75 -50 -25 0.0 25 50 75 100 125 150 175 T<sub>J</sub>, Junction Temperature (°C)

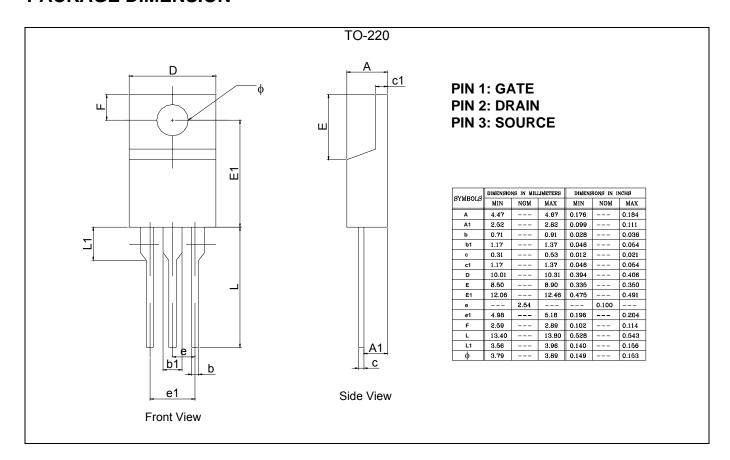








### **PACKAGE DIMENSION**





#### **IMPORTANT NOTICE**

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